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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	·
Number of Logic Elements/Cells	1536
Total RAM Bits	18432
Number of I/O	71
Number of Gates	60000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	100-TQFP
Supplier Device Package	100-VQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/agln060v5-vqg100i

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Device Marking

Microsemi normally topside marks the full ordering part number on each device. There are some exceptions to this, such as some of the Z feature grade nano devices, the V2 designator for IGLOO devices, and packages where space is physically limited. Packages that have limited characters available are UC36, UC81, CS81, QN48, QN68, and QFN132. On these specific packages, a subset of the device marking will be used that includes the required legal information and as much of the part number as allowed by character limitation of the device. In this case, devices will have a truncated device marking and may exclude the applications markings, such as the I designator for Industrial Devices or the ES designator for Engineering Samples.

Figure 1 shows an example of device marking based on the AGLN250V2-CSG81. The actual mark will vary by the device/package combination ordered.

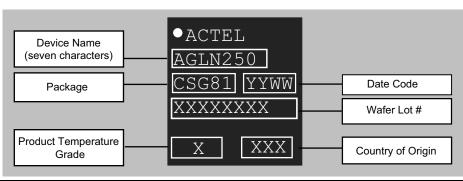


Figure 1 • Example of Device Marking for Small Form Factor Packages

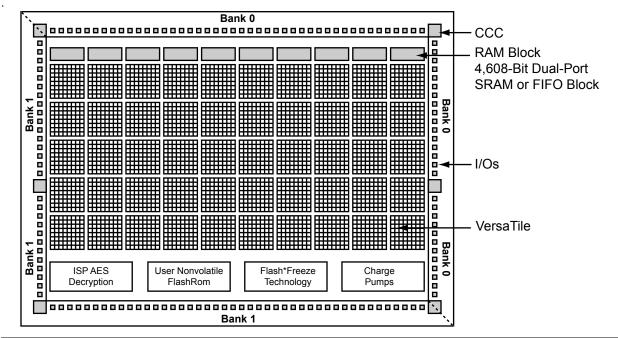


Figure 1-3 • IGLOO Device Architecture Overview with Two I/O Banks (AGLN060, AGLN125)

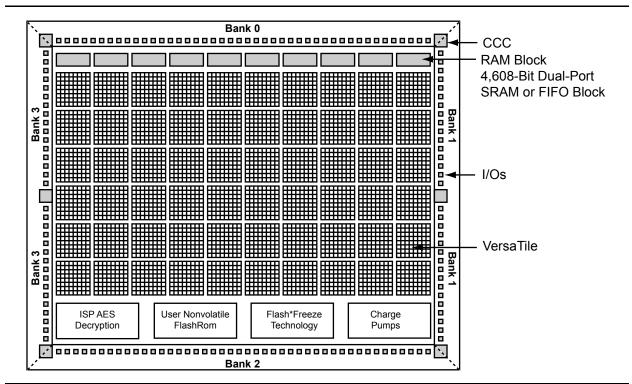


Figure 1-4 • IGLOO Device Architecture Overview with Four I/O Banks (AGLN250)

IGLOO nano DC and Switching Characteristics

Symbol	Р	arameter	Extended Commercial	Industrial	Units
TJ	Junction temperature		$-20 \text{ to } + 85^2$	$-40 \text{ to } +100^2$	°C
VCC	1.5 V DC core supply vo	oltage ³	1.425 to 1.575	1.425 to 1.575	V
	1.2 V–1.5 V wide range	core voltage ^{4,5}	1.14 to 1.575	1.14 to 1.575	V
VJTAG	JTAG DC voltage		1.4 to 3.6	1.4 to 3.6	V
VPUMP ⁶	Programming voltage	Programming mode	3.15 to 3.45	3.15 to 3.45	V
		Operation	0 to 3.6	0 to 3.6	V
VCCPLL ⁷	•	1.5 V DC core supply voltage ³	1.425 to 1.575	1.425 to 1.575	V
	CPLL' Analog power supply (PLL)	1.2 V–1.5 V wide range core supply voltage ⁴	1.14 to 1.575	1.14 to 1.575	V
VCCI and	1.2 V DC supply voltage	4	1.14 to 1.26	1.14 to 1.26	V
VMV ^{8,9}	1.2 V DC wide range su	pply voltage ⁴	1.14 to 1.575	1.14 to 1.575	V
	1.5 V DC supply voltage)	1.425 to 1.575	1.425 to 1.575	V
	1.8 V DC supply voltage)	1.7 to 1.9	1.7 to 1.9	V
	2.5 V DC supply voltage)	2.3 to 2.7	2.3 to 2.7	V
	3.3 V DC supply voltage)	3.0 to 3.6	3.0 to 3.6	V
	3.3 V DC wide range su	pply voltage ¹⁰	2.7 to 3.6	2.7 to 3.6	V

Table 2-2 • Recommended Operating Conditions ¹

Notes:

1. All parameters representing voltages are measured with respect to GND unless otherwise specified.

2. Default Junction Temperature Range in the Libero SoC software is set to 0°C to +70°C for commercial, and -40°C to +85°C for industrial. To ensure targeted reliability standards are met across the full range of junction temperatures, Microsemi recommends using custom settings for temperature range before running timing and power analysis tools. For more information regarding custom settings, refer to the New Project Dialog Box in the Libero Online Help.

3. For IGLOO[®] nano V5 devices

- 4. For IGLOO nano V2 devices only, operating at VCCI ≥ VCC
- IGLOO nano V5 devices can be programmed with the VCC core voltage at 1.5 V only. IGLOO nano V2 devices can be programmed with the VCC core voltage at 1.2 V (with FlashPro4 only) or 1.5 V. If you are using FlashPro3 and want to do in-system programming using 1.2 V, please contact the factory.
- 6. V_{PUMP} can be left floating during operation (not programming mode).
- 7. VCCPLL pins should be tied to VCC pins. See the "Pin Descriptions" chapter for further information.

8. VMV pins must be connected to the corresponding VCCI pins. See the Pin Descriptions chapter of the IGLOO nano FPGA Fabric User's Guide for further information.

9. The ranges given here are for power supplies only. The recommended input voltage ranges specific to each I/O standard are given in Table 2-21 on page 2-19. VCCI should be at the same voltage within a given I/O bank.

10. 3.3 V wide range is compliant to the JESD8-B specification and supports 3.0 V VCCI operation.

Table 2-3 • Flash Programming Limits – Retention, Storage, and Operating Temperature¹

Product Grade	Programming Cycles	Program Retention (biased/unbiased)	Maximum Storage Temperature T _{STG} (°C) ²	Maximum Operating Junction Temperature T _J (°C) ²
Commercial	500	20 years	110	100
Industrial	500	20 years	110	100
Notes:			•	•

Notes:

1. This is a stress rating only; functional operation at any condition other than those indicated is not implied.

 These limits apply for program/data retention only. Refer to Table 2-1 on page 2-1 and Table 2-2 for device operating conditions and absolute limits.

IGLOO nano DC and Switching Characteristics

	Core Voltage	AGLN010	AGLN015	AGLN020	AGLN060	AGLN125	AGLN250	Units
VCCI= 1.2 V (per bank) Typical (25°C)	1.2 V	1.7	1.7	1.7	1.7	1.7	1.7	μA
VCCI = 1.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.8	1.8	1.8	1.8	1.8	1.8	μA
VCCI = 1.8 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.9	1.9	1.9	1.9	1.9	1.9	μA
VCCI = 2.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.2	2.2	2.2	2.2	2.2	2.2	μA
VCCI = 3.3 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.5	2.5	2.5	2.5	2.5	2.5	μA

Table 2-10 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Sleep Mode*

Note: *I_{DD} = N_{BANKS} * I_{CCI}.

Table 2-11 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Shutdown Mode

	Core Voltage	AGLN010	AGLN015	AGLN020	AGLN060	AGLN125	AGLN250	Units
Typical (25°C)	1.2 V / 1.5 V	0	0	0	0	0	0	μA

Table 2-12 • Quiescent Supply Current (IDD), No IGLOO nano Flash*Freeze Mode¹

	Core Voltage	AGLN010	AGLN015	AGLN020	AGLN060	AGLN125	AGLN250	Units
ICCA Current ²		•						
Typical (25°C)	1.2 V	3.7	5	5	10	13	18	μA
	1.5 V	8	14	14	20	28	44	μA
ICCI or IJTAG Current		-						
VCCI / VJTAG = 1.2 V (per bank) Typical (25°C)	1.2 V	1.7	1.7	1.7	1.7	1.7	1.7	μA
VCCI / VJTAG = 1.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.8	1.8	1.8	1.8	1.8	1.8	μA
VCCI / VJTAG = 1.8 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.9	1.9	1.9	1.9	1.9	1.9	μA
VCCI / VJTAG = 2.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.2	2.2	2.2	2.2	2.2	2.2	μA
VCCI / VJTAG = 3.3 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.5	2.5	2.5	2.5	2.5	2.5	μA

Notes:

IDD = N_{BANKS} * ICCI + ICCA. JTAG counts as one bank when powered.
 Includes VCC, VCCPLL, and VPUMP currents.

IGLOO nano DC and Switching Characteristics

Applies to IGLOO nano at 1.2 V Core Operating Conditions

Table 2-26 • Summary of I/O Timing Characteristics—Software Default SettingsSTD Speed Grade, Commercial-Case Conditions: TJ = 70°C, Worst-Case VCC = 1.14 V,Worst-Case VCCI = 3.0 V

	-														
I/O Standard	Drive Strength (mA)	Equiv. Software Default Drive Strength Option ¹	Slew Rate	Capacitive Load (pF)	teouт	t _{DP}	t _{DIN}	t _P Y)	t _{PYS}	teour	t _{zı}	tzн	t _{LZ}	t _{HZ}	Units
3.3 V LVTTL / 3.3 V LVCMOS	8 mA	8 mA	High	5 pF	1.55	2.31	0.26	0.97	1.36	1.10	2.34	1.90	2.43	3.14	ns
3.3 V LVCMOS Wide Range ²	100 µA	8 mA	High	5 pF	1.55	3.25	0.26	1.31	1.91	1.10	3.25	2.61	3.38	4.27	ns
2.5 V LVCMOS	8 mA	8 mA	High	5 pF	1.55	2.30	0.26	1.21	1.39	1.10	2.33	2.04	2.41	2.99	ns
1.8 V LVCMOS	4 mA	4 mA	High	5 pF	1.55	2.49	0.26	1.13	1.59	1.10	2.53	2.34	2.42	2.81	ns
1.5 V LVCMOS	2 mA	2 mA	High	5 pF	1.55	2.78	0.26	1.27	1.77	1.10	2.82	2.62	2.44	2.74	ns
1.2 V LVCMOS	1 mA	1 mA	High	5 pF	1.55	3.50	0.26	1.56	2.27	1.10	3.37	3.10	2.55	2.66	ns
1.2 V LVCMOS Wide Range ³	100 µA	1 mA	High	5 pF	1.55	3.50	0.26	1.56	2.27	1.10	3.37	3.10	2.55	2.66	ns

Notes:

 The minimum drive strength for any LVCMOS 1.2 V or LVCMOS 3.3 V software configuration when run in wide range is ±100 μA. Drive strength displayed in the software is supported for normal range only. For a detailed I/V curve, refer to the IBIS models.

2. All LVCMOS 3.3 V software macros support LVCMOS 3.3 V wide range, as specified in the JESD8-B specification.

3. All LVCMOS 1.2 V software macros support LVCMOS 1.2 V side range as specified in the JESD8-12 specification.

4. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

IGLOO nano DC and Switching Characteristics

Single-Ended I/O Characteristics

3.3 V LVTTL / 3.3 V LVCMOS

Low-Voltage Transistor–Transistor Logic (LVTTL) is a general purpose standard (EIA/JESD) for 3.3 V applications. It uses an LVTTL input buffer and push-pull output buffer.

3.3 V LVTTL / 3.3 V LVCMOS	VIL		VIH		VOL	VOH	IOL	юн	IOSL	IOSH	IIL ¹	IIH ²
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μA ⁴	μA ⁴
2 mA	-0.3	0.8	2	3.6	0.4	2.4	2	2	25	27	10	10
4 mA	-0.3	0.8	2	3.6	0.4	2.4	4	4	25	27	10	10
6 mA	-0.3	0.8	2	3.6	0.4	2.4	6	6	51	54	10	10
8 mA	-0.3	0.8	2	3.6	0.4	2.4	8	8	51	54	10	10

Table 2-34 • Minimum and Maximum DC Input and Output Levels

Notes:

1. I_{IL} is the input leakage current per I/O pin over recommended operating conditions where -0.3 < VIN < VIL.

2. I_{IH} is the input leakage current per I/O pin over recommended operating conditions where VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges.

3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.

4. Currents are measured at 85°C junction temperature.

5. Software default selection highlighted in gray.

Test Point
$$rac{1}{5}$$
 pF $R = 1 k$
Datapath $rac{1}{5}$ pF $R = 1 k$
Enable Path $rac{1}{5}$ pF for $t_{LZ} / t_{ZL} / t_{ZLS}$
 $rac{1}{5}$ pF for $t_{ZH} / t_{ZHS} / t_{ZL} / t_{ZLS}$

Figure 2-7 • AC Loading

Table 2-35 • 3.3 V LVTTL/LVCMOS AC Waveforms, Measuring Points, and Capacitive Loads

Input LOW (V)	Input HIGH (V)	Measuring Point* (V)	C _{LOAD} (pF)
0	3.3	1.4	5

Note: *Measuring point = Vtrip. See Table 2-23 on page 2-20 for a complete table of trip points.

Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-47 • 2.5 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	4.13	0.19	1.10	1.24	0.66	4.01	4.13	1.73	1.74	ns
4 mA	STD	0.97	4.13	0.19	1.10	1.24	0.66	4.01	4.13	1.73	1.74	ns
8 mA	STD	0.97	3.39	0.19	1.10	1.24	0.66	3.31	3.39	1.98	2.19	ns
8 mA	STD	0.97	3.39	0.19	1.10	1.24	0.66	3.31	3.39	1.98	2.19	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-48 • 2.5 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 2.3 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	2.19	0.19	1.10	1.24	0.66	2.23	2.11	1.72	1.80	ns
4 mA	STD	0.97	2.19	0.19	1.10	1.24	0.66	2.23	2.11	1.72	1.80	ns
6 mA	STD	0.97	1.81	0.19	1.10	1.24	0.66	1.85	1.63	1.97	2.26	ns
8 mA	STD	0.97	1.81	0.19	1.10	1.24	0.66	1.85	1.63	1.97	2.26	ns

Notes:

1. Software default selection highlighted in gray.

2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

IGLOO nano DC and Switching Characteristics

Timing Characteristics

Applies to 1.5 V DC Core Voltage

Table 2-59 • 1.5 V LVCMOS Low Slew – Applies to 1.5 V DC Core Voltage

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	5.39	0.19	1.19	1.62	0.66	5.48	5.39	2.02	2.06	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-60 • 1.5 V LVCMOS High Slew – Applies to 1.5 V DC Core Voltage Commercial-Case Conditions: T₁ = 70°C, Worst-Case VCC = 1.425 V, Worst-Case VCCI = 1.4 V

			J	,				,				
Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{zH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	0.97	2.39	0.19	1.19	1.62	0.66	2.44	2.24	2.02	2.15	ns

Notes:

1. Software default selection highlighted in gray.

2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Applies to 1.2 V DC Core Voltage

Table 2-61 • 1.5 V LVCMOS Low Slew – Applies to 1.2 V DC Core Voltage Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	1.55	5.87	0.26	1.27	1.77	1.10	5.92	5.87	2.45	2.65	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

Table 2-62 • 1.5 V LVCMOS High Slew – Applies to 1.2 V DC Core Voltage Commercial Case Conditional T = 70°C Worst Case VCC = 1.14 V

Commercial-Case Conditions: T_J = 70°C, Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Drive Strength	Speed Grade	t _{DOUT}	t _{DP}	t _{DIN}	t _{PY}	t _{PYS}	t _{EOUT}	t _{ZL}	t _{ZH}	t _{LZ}	t _{HZ}	Units
2 mA	STD	1.55	2.78	0.26	1.27	1.77	1.10	2.82	2.62	2.44	2.74	ns

Notes:

1. Software default selection highlighted in gray.

2. For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

IGLOO nano DC and Switching Characteristics

Table 2-96 • AGLN020 Global ResourceCommercial-Case Conditions: TJ = 70°C, VCC = 1.14 V

		S	Std.	
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	1.81	2.26	ns
t _{RCKH}	Input High Delay for Global Clock	1.90	2.51	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.61	ns

Notes:

1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).

2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).

3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.

Table 2-97 • AGLN060 Global Resource

Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

		S	Std.	
Parameter	Description	Min. ¹	Max. ²	Units
t _{RCKL}	Input Low Delay for Global Clock	2.02	2.42	ns
t _{RCKH}	Input High Delay for Global Clock	2.09	2.65	ns
t _{RCKMPWH}	Minimum Pulse Width High for Global Clock	1.40		ns
t _{RCKMPWL}	Minimum Pulse Width Low for Global Clock	1.65		ns
t _{RCKSW}	Maximum Skew for Global Clock		0.56	ns

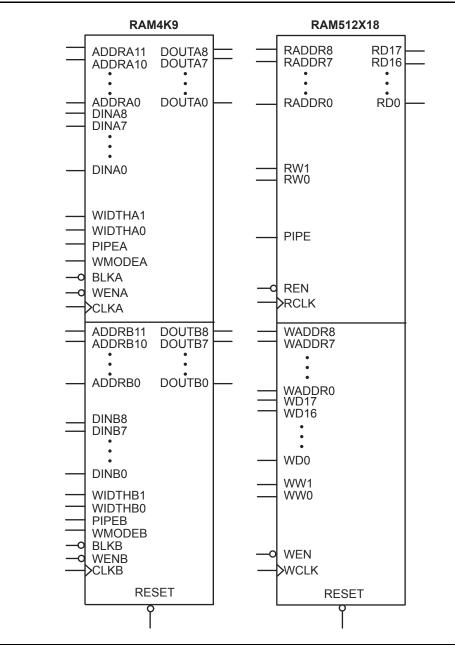
Notes:

1. Value reflects minimum load. The delay is measured from the CCC output to the clock pin of a sequential element, located in a lightly loaded row (single element is connected to the global net).

2. Value reflects maximum load. The delay is measured on the clock pin of the farthest sequential element, located in a fully loaded row (all available flip-flops are connected to the global net in the row).

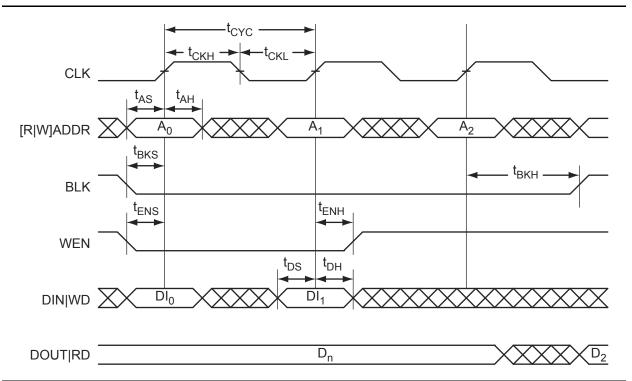
3. For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.

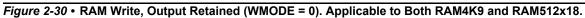
Embedded SRAM and FIFO Characteristics

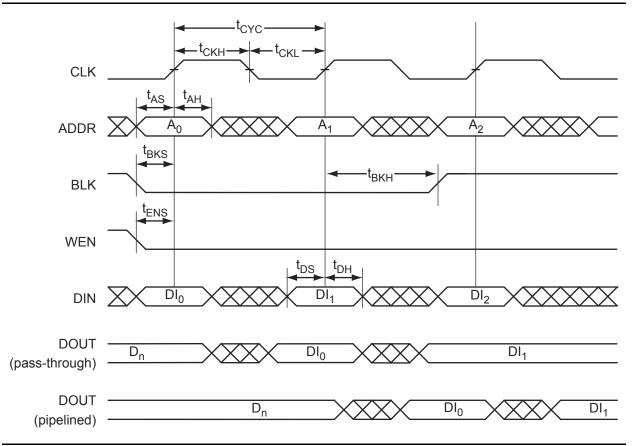


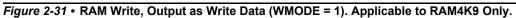
SRAM

Figure 2-27 • RAM Models



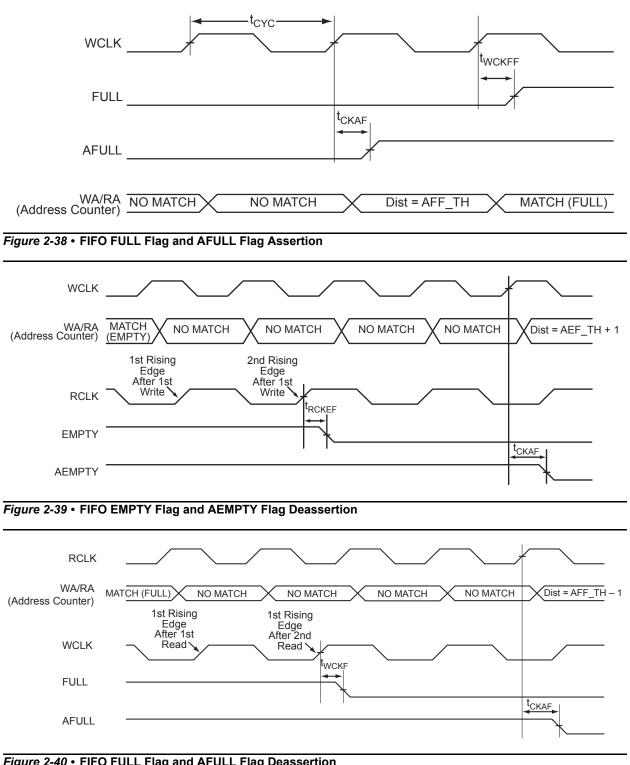


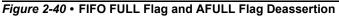






IGLOO nano DC and Switching Characteristics





IGLOO nano DC and Switching Characteristics

1.2 V DC Core Voltage

Table 2-107 • FIFO

Worst Commercial-Case Conditions: T_J = 70°C, VCC = 1.14 V

Parameter	Description	Std.	Units
t _{ENS}	REN, WEN Setup Time	3.44	ns
t _{ENH}	REN, WEN Hold Time	0.26	ns
t _{BKS}	BLK Setup Time	0.30	ns
t _{BKH}	BLK Hold Time	0.00	ns
t _{DS}	Input Data (DI) Setup Time	1.30	ns
t _{DH}	Input Data (DI) Hold Time	0.41	ns
t _{CKQ1}	Clock High to New Data Valid on RD (flow-through)	5.67	ns
t _{CKQ2}	Clock High to New Data Valid on RD (pipelined)	3.02	ns
t _{RCKEF}	RCLK High to Empty Flag Valid	6.02	ns
t _{WCKFF}	WCLK High to Full Flag Valid	5.71	ns
t _{CKAF}	Clock High to Almost Empty/Full Flag Valid	22.17	ns
t _{RSTFG}	RESET LOW to Empty/Full Flag Valid	5.93	ns
t _{RSTAF}	RESET LOW to Almost Empty/Full Flag Valid	21.94	ns
t _{RSTBQ}	RESET LOW to Data Out Low on RD (flow-through)	3.41	ns
	RESET LOW to Data Out Low on RD (pipelined)	4.09	3.41
t _{REMRSTB}	RESET Removal	1.02	ns
t _{RECRSTB}	RESET Recovery	5.48	ns
t _{MPWRSTB}	RESET Minimum Pulse Width	1.18	ns
t _{CYC}	Clock Cycle Time	10.90	ns
F _{MAX}	Maximum Frequency for FIFO	92	MHz

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-7 for derating values.



Package Pin Assignments

UC36						
AGLN010						
Pin Number	Function					
A1	IO21RSB1					
A2	IO18RSB1					
A3	IO13RSB1					
A4	GDC0/IO00RSB0					
A5	IO06RSB0					
A6	GDA0/IO04RSB0					
B1	GEC0/IO37RSB1					
B2	IO20RSB1					
B3	IO15RSB1					
B4	IO09RSB0					
B5	IO08RSB0					
B6	IO07RSB0					
C1	IO22RSB1					
C2	GEA0/IO34RSB1					
C3	GND					
C4	GND					
C5	VCCIB0					
C6	IO02RSB0					
D1	IO33RSB1					
D2	VCCIB1					
D3	VCC					
D4	VCC					
D5	IO10RSB0					
D6	IO11RSB0					
E1	IO32RSB1					
E2	FF/IO31RSB1					
E3	ТСК					
E4	VPUMP					
E5	TRST					
E6	VJTAG					
F1	IO29RSB1					
F2	IO25RSB1					
F3	IO23RSB1					
F4	TDI					

UC36					
Pin Number	AGLN010 Function				
F5	TMS				
F6	TDO				



Package Pin Assignments

	CS81	CS81				
Pin Number	AGLN030Z Function	Pin Number	AGLN030Z Function			
A1	IO00RSB0	D9	IO30RSB0			
A2	IO02RSB0	E1	GEB0/IO71RSB			
A3	IO06RSB0	E2	GEA0/IO72RSB			
A4	IO11RSB0	E3	GEC0/IO73RSB			
A5	IO16RSB0	E4	VCCIB1			
A6	IO19RSB0	E5	VCC			
A7	IO22RSB0	E6	VCCIB0			
A8	IO24RSB0	E7	GDC0/IO32RSB			
A9	IO26RSB0	E8	GDA0/IO33RSB			
B1	IO81RSB1	E9	GDB0/IO34RSB			
B2	IO04RSB0	F1	IO68RSB1			
B3	IO10RSB0	F2	IO67RSB1			
B4	IO13RSB0	F3	IO64RSB1			
B5	IO15RSB0	F4	GND			
B6	IO20RSB0	F5	VCCIB1			
B7	IO21RSB0	F6	IO47RSB1			
B8	IO28RSB0	F7	IO36RSB0			
B9	IO25RSB0	F8	IO38RSB0			
C1	IO79RSB1	F9	IO40RSB0			
C2	IO80RSB1	G1	IO65RSB1			
C3	IO08RSB0	G2	IO66RSB1			
C4	IO12RSB0	G3	IO57RSB1			
C5	IO17RSB0	G4	IO53RSB1			
C6	IO14RSB0	G5	IO49RSB1			
C7	IO18RSB0	G6	IO44RSB1			
C8	IO29RSB0	G7	IO46RSB1			
C9	IO27RSB0	G8	VJTAG			
D1	IO74RSB1	G9	TRST			
D2	IO76RSB1	H1	IO62RSB1			
D3	IO77RSB1	H2	FF/IO60RSB1			
D4	VCC	H3	IO58RSB1			
D5	VCCIB0	H4	IO54RSB1			
D6	GND	H5	IO48RSB1			
D7	IO23RSB0	H6	IO43RSB1			
D8	IO31RSB0	H7	IO42RSB1			

	CS81
Pin Number	AGLN030Z Function
H8	TDI
H9	TDO
J1	IO63RSB1
J2	IO61RSB1
J3	IO59RSB1
J4	IO56RSB1
J5	IO52RSB1
J6	IO45RSB1
J7	ТСК
J8	TMS
J9	VPUMP

IGLOO nano Low Power Flash FPGAs

VQ100			VQ100	VQ100			
Pin Number	AGLN125Z Function	Pin Number	AGLN125Z Function	Pin Number	AGLN125Z Function		
1	GND	36	IO93RSB1	71	GBB2/IO43RSB0		
2	GAA2/IO67RSB1	37	VCC	72	IO42RSB0		
3	IO68RSB1	38	GND	73	GBA2/IO41RSB0		
4	GAB2/IO69RSB1	39	VCCIB1	74	VMV0		
5	IO132RSB1	40	IO87RSB1	75	GNDQ		
6	GAC2/IO131RSB1	41	IO84RSB1	76	GBA1/IO40RSB0		
7	IO130RSB1	42	IO81RSB1	77	GBA0/IO39RSB0		
8	IO129RSB1	43	IO75RSB1	78	GBB1/IO38RSB0		
9	GND	44	GDC2/IO72RSB1	79	GBB0/IO37RSB0		
10	GFB1/IO124RSB1	45	GDB2/IO71RSB1	80	GBC1/IO36RSB0		
11	GFB0/IO123RSB1	46	GDA2/IO70RSB1	81	GBC0/IO35RSB0		
12	VCOMPLF	47	TCK	82	IO32RSB0		
13	GFA0/IO122RSB1	48	TDI	83	IO28RSB0		
14	VCCPLF	49	TMS	84	IO25RSB0		
15	GFA1/IO121RSB1	50	VMV1	85	IO22RSB0		
16	GFA2/IO120RSB1	51	GND	86	IO19RSB0		
17	VCC	52	VPUMP	87	VCCIB0		
18	VCCIB1	53	NC	88	GND		
19	GEC0/IO111RSB1	54	TDO	89	VCC		
20	GEB1/IO110RSB1	55	TRST	90	IO15RSB0		
21	GEB0/IO109RSB1	56	VJTAG	91	IO13RSB0		
22	GEA1/IO108RSB1	57	GDA1/IO65RSB0	92	IO11RSB0		
23	GEA0/IO107RSB1	58	GDC0/IO62RSB0	93	IO09RSB0		
24	VMV1	59	GDC1/IO61RSB0	94	IO07RSB0		
25	GNDQ	60	GCC2/IO59RSB0	95	GAC1/IO05RSB0		
26	GEA2/IO106RSB1	61	GCB2/IO58RSB0	96	GAC0/IO04RSB0		
27	FF/GEB2/IO105RSB1	62	GCA0/IO56RSB0	97	GAB1/IO03RSB0		
28	GEC2/IO104RSB1	63	GCA1/IO55RSB0	98	GAB0/IO02RSB0		
29	IO102RSB1	64	GCC0/IO52RSB0	99	GAA1/IO01RSB0		
30	IO100RSB1	65	GCC1/IO51RSB0	100	GAA0/IO00RSB0		
31	IO99RSB1	66	VCCIB0	L			
32	IO97RSB1	67	GND				
33	IO96RSB1	68	VCC				
34	IO95RSB1	69	IO47RSB0				
35	IO94RSB1	70	GBC2/IO45RSB0				

5 – Datasheet Information

List of Changes

The following table lists critical changes that were made in each version of the IGLOO nano datasheet.

Revision	Changes	Page
Revision 19 (October 2015)	Modified the note to include device/package obsoletion information in "Features and Benefits" section (SAR 69724).	1-I
	Added a note under Security Feature "Y" in "IGLOO nano Ordering Information" section (SAR 70553).	1-IV
	Modified AGLN250 pin assignment table to match with I/O Attribute Editor tool from Libero in "CS81" Package (SAR 59049).	4-6
	Modified the nominal area to 25 for CS81 Package in Table 1 (SAR 71127).	1-II
	Modified the title of AGLN125Z pin assignment table for "CS81" Package (SAR 71127).	4-6
Revision 18 (November 2013)	Modified the "Device Marking" section and updated Figure 1 • Example of Device Marking for Small Form Factor Packages to reflect updates suggested per CN1004 published on 5/10/2010 (SAR 52036).	V
Revision 17 (May 2013)	Deleted details related to Ambient temperature from "Enhanced Commercial Temperature Range", "IGLOO nano Ordering Information", "Temperature Grade Offerings", and Table 2-2 • Recommended Operating Conditions ¹ to remove ambiguities arising due to the same, and modified Note 2 (SAR 47063).	I, IV, VI, and 2-2
Revision 16 (December 2012)	The "IGLOO nano Ordering Information" section has been updated to mention "Y" as "Blank" mentioning "Device Does Not Include License to Implement IP Based on the Cryptography Research, Inc. (CRI) Patent Portfolio" (SAR 43174).	IV
	The note in Table 2-100 • IGLOO nano CCC/PLL Specification and Table 2-101 • IGLOO nano CCC/PLL Specification referring the reader to SmartGen was revised to refer instead to the online help associated with the core (SAR 42565).	2-70, 2-71
	Live at Power-Up (LAPU) has been replaced with 'Instant On'.	NA
Revision 15 (September 2012)	The status of the AGLN125 device has been modified from 'Advance' to 'Production' in the "IGLOO nano Device Status" section (SAR 41416).	III
	Libero Integrated Design Environment (IDE) was changed to Libero System-on-Chip (SoC) throughout the document (SAR 40274).	NA
Revision 14 (September 2012)	The "Security" section was modified to clarify that Microsemi does not support read-back of programmed data.	1-2
Revision 13 (June 2012)	Figure Figure 2-34 • FIFO Read and Figure 2-35 • FIFO Write have been added (SAR 34842).	2-82
	The following sentence was removed from the "VMVx I/O Supply Voltage (quiet)" section in the "Pin Descriptions" section: "Within the package, the VMV plane is decoupled from the simultaneous switching noise originating from the output buffer VCCI domain" and replaced with "Within the package, the VMV plane biases the input stage of the I/Os in the I/O banks" (SAR 38319). The datasheet mentions that "VMV pins must be connected to the corresponding VCCI pins" for an ESD enhancement.	3-1

Revision	Changes	Page
Revision 11 (Jul 2010)	The status of the AGLN060 device has changed from Advance to Production.	
	The values for PAC1, PAC2, PAC3, and PAC4 were updated in Table 2-15 • Different Components Contributing to Dynamic Power Consumption in IGLOO nano Devices for 1.5 V core supply voltage (SAR 26404).	2-10
	The values for PAC1, PAC2, PAC3, and PAC4 were updated in Table 2-17 • Different Components Contributing to Dynamic Power Consumption in IGLOO nano Devices for 1.2 V core supply voltage (SAR 26404).	2-11
July 2010	The versioning system for datasheets has been changed. Datasheets are assigned a revision number that increments each time the datasheet is revised. The "IGLOO nano Device Status" table on page III indicates the status for each device in the device family.	N/A
Revision 10 (Apr 2010)	References to differential inputs were removed from the datasheet, since IGLOO nano devices do not support differential inputs (SAR 21449).	N/A
	A parenthetical note, "hold previous I/O state in Flash*Freeze mode," was added to each occurrence of bus hold in the datasheet (SAR 24079).	N/A
	The "In-System Programming (ISP) and Security" section was revised to add 1.2 V programming.	I
	The note connected with the "IGLOO nano Ordering Information" table was revised to clarify features not available for Z feature grade devices.	IV
	The "IGLOO nano Device Status" table is new.	
	The definition of C in the "Temperature Grade Offerings" table was changed to "extended commercial temperature range".	VI
	1.2 V wide range was added to the list of voltage ranges in the "I/Os with Advanced I/O Standards" section.	1-8
	A note was added to Table 2-2 • Recommended Operating Conditions ¹ regarding switching from 1.2 V to 1.5 V core voltage for in-system programming. The VJTAG voltage was changed from "1.425 to 3.6" to "1.4 to 3.6" (SAR 24052). The note regarding voltage for programming V2 and V5 devices was revised (SAR 25213). The maximum value for VPUMP programming voltage (operation mode) was changed from 3.45 V to 3.6 V (SAR 25220).	2-2
	Table 2-6 • Temperature and Voltage Derating Factors for Timing Delays (normalized to $TJ = 70^{\circ}C$, VCC = 1.425 V) and Table 2-7 • Temperature and Voltage Derating Factors for Timing Delays (normalized to $TJ = 70^{\circ}C$, VCC = 1.14 V) were updated. Table 2-8 • Power Supply State per Mode is new.	2-6, 2-7
	The tables in the "Quiescent Supply Current" section were updated (SAR 24882 and SAR 24112).	2-7
	VJTAG was removed from Table 2-10 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Sleep Mode* (SARs 24112, 24882, and 79503).	2-8
	The note stating what was included in I _{DD} was removed from Table 2-11 • Quiescent Supply Current (IDD) Characteristics, IGLOO nano Shutdown Mode. The note, "per VCCI or VJTAG bank" was removed from Table 2-12 • Quiescent Supply Current (IDD), No IGLOO nano Flash*Freeze Mode ¹ . The note giving I _{DD} was changed to "I _{DD} = $N_{BANKS} * I_{CCI} + I_{CCA}$."	2-8
	The values in Table 2-13 • Summary of I/O Input Buffer Power (per pin) – Default I/O Software Settings and Table 2-14 • Summary of I/O Output Buffer Power (per pin) – Default I/O Software Settings ¹ were updated. Wide range support information was added.	2-9

IGLOO nano Low Power Flash FPGAs

Revision / Version	Changes	Page
Revision 9 (Mar2010) Product Brief Advance v0.9 Packaging Advance v0.8	All product tables and pin tables were updated to show clearly that AGLN030 is available only in the Z feature grade at this time. The nano-Z feature grade devices are designated with a Z at the end of the part number.	
Revision 8 (Jan 2009)	The "Reprogrammable Flash Technology" section was revised to add "250 MHz (1.5 V systems) and 160 MHz (1.2 V systems) System Performance".	I
Product Brief Advance v0.8	The note for AGLN030 in the "IGLOO nano Devices" table and "I/Os Per Package" table was revised to remove the statement regarding package compatibility with lower density nano devices.	
	The "I/Os with Advanced I/O Standards" section was revised to add definitions for hot-swap and cold-sparing.	1-8
Packaging Advance v0.7	The "UC81", "CS81", "QN48", and "QN68" pin tables for AGLN030 are new.	4-5, 4-8, 4-17,4-21
	The "CS81"pin table for AGLN060 is new.	4-9
	The "CS81" and "VQ100" pin tables for AGLN060Z are new.	4-10, 4-25
	The "CS81" and "VQ100" pin tables for AGLN125Z are new.	4-12, 4-27
	The "CS81" and "VQ100" pin tables for AGLN250Z is new.	4-14, 4-29
Revision 7 (Apr 2009) Product Brief Advance v0.7 DC and Switching Characteristics Advance v0.3	The –F speed grade is no longer offered for IGLOO nano devices and was removed from the datasheet.	N/A
Revision 6 (Mar 2009)	The "VQ100" pin table for AGLN030 is new.	4-23
Packaging Advance v0.6		
Revision 5 (Feb 2009) Packaging Advance v0.5	The "100-Pin QFN" section was removed.	N/A
Revision 4 (Feb 2009)	The QN100 package was removed for all devices.	N/A
Product Brief Advance v0.6	"IGLOO nano Devices" table was updated to change the maximum user I/Os for AGLN030 from 81 to 77.	II
	The "Device Marking" section is new.	V
Revision 3 (Feb 2009) Product Brief Advance v0.5	The following table note was removed from "IGLOO nano Devices" table: "Six chip (main) and three quadrant global networks are available for AGLN060 and above."	
	The CS81 package was added for AGLN250 in the "IGLOO nano Products Available in the Z Feature Grade" table.	VI
Packaging Advance v0.4	The "UC81" and "CS81" pin tables for AGLN020 are new.	4-4, 4-7
	The "CS81" pin table for AGLN250 is new.	4-13

IGLOO nano Low Power Flash FPGAs

Revision / Version	Changes	Page
Revision 1 (cont'd)	The "QN48" pin diagram was revised.	4-16
Packaging Advance v0.2	Note 2 for the "QN48", "QN68", and "100-Pin QFN" pin diagrams was changed to "The die attach paddle of the package is tied to ground (GND)."	4-16, 4-19
	The "VQ100" pin diagram was revised to move the pin IDs to the upper left corner instead of the upper right corner.	4-23
Revision 0 (Oct 2008) Product Brief Advance v0.2	The following tables and sections were updated to add the UC81 and CS81 packages for AGL030: "IGLOO nano Devices" "I/Os Per Package" "IGLOO nano Products Available in the Z Feature Grade" "Temperature Grade Offerings"	N/A
	The "I/Os Per Package" table was updated to add the following information to table note 4: "For nano devices, the VQ100 package is offered in both leaded and RoHS-compliant versions. All other packages are RoHS-compliant only."	II
	The "IGLOO nano Products Available in the Z Feature Grade" section was updated to remove QN100 for AGLN250.	VI
	The device architecture figures, Figure 1-3 • IGLOO Device Architecture Overview with Two I/O Banks (AGLN060, AGLN125) through Figure 1-4 • IGLOO Device Architecture Overview with Four I/O Banks (AGLN250), were revised. Figure 1-1 • IGLOO Device Architecture Overview with Two I/O Banks and No RAM (AGLN010 and AGLN030) is new.	1-4 through 1-5
	The "PLL and CCC" section was revised to include information about CCC-GLs in AGLN020 and smaller devices.	1-7
	The "I/Os with Advanced I/O Standards" section was revised to add information about IGLOO nano devices supporting double-data-rate applications.	1-8